IFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Van Steenkiste et al.. Group Art Unit 1762

Attorney Docket Number **DP-306711CIP1**

Serial No. 10/616,490 Filed: July 9, 2003

Title: Spray System With Combined Kinetic Spray And Thermal Spray Ability

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: MS: DD, Commissioner For Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on 4-21-2005.

Lowell M. Train

STATEMENT ACCOMPANYING

INFORMATION DISCLOSURE STATEMENT

Applicant(s) requests the Examiner to consider and make of record the reference(s) and/or information on attached PTO 1449.

CHECK ONE: (A, B, or C.)

[ ] A. This statement is submitted within 1) three months after the filing date (even if after the first action); or 2) within three months of the date of entry of the national stage or 3) before the mailing date of a first Office Action. No fee or statement is required.

[XX`] B. This statement is submitted after the period specified in para. A, but before Final Office Action or Notice of Allowance or the close of prosecution.

CHECK ONE: (1, 2, or 3)

[ ] 1. I hereby state that each item of information contained in the information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement; or

[ ] 2. I hereby state that no item of information contained in the information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing the certification after making reasonable inquiry, no item of information contained in the information disclosure statement was known to any individual designated in § 1.56 (c) more than three months prior to the filing of the information disclosure statement.

[ ] 3. Charge the fee set forth in § 1.17(p) to Delphi Technologies, Inc. Deposit Account No. 50-0831.

[ ] C. This statement is submitted after a Final Office Action or Notice of Allowance or the close of prosecution, but before payment of the issue fee. Charge the fee set forth in § 1.17(p) to Delphi Technologies, Inc. Deposit Account No. 50-0831.

CHECK ONE: (1 or 2)

[ ] 1. I hereby state that each item of information contained in the information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement; or

[ ] 2. I hereby state that no item of information contained in the information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing the certification after making reasonable inquiry, no item of information contained in the information disclosure statement was known to any individual designated in § 1.56 (c) more than three months prior to the filing of the information disclosure statement.

REMARKS UNDER 1.98 (a)(3)

The non-English language documents submitted herewith are relevant because they disclose spray coating of articles.

Please consider the attached reference(s) which have come to the attention of Applicants since the last submission of an IDS. If any fee should be required, please charge the appropriate fee to Delphi Technologies, Inc. Deposit Account No. 50-0831.

Respectfully submitted,

SCOTT A. McBAIN
Reg. No. 37,181
Telephone (248) 813-1235

enc: PTO 1449

INFORMATION DISCLOSURE CITATION WITH DOCUMENT COPIES

Submitted by:	Atty. Docket No.	Serial No.
SCOTT A. MCBAIN Delphi Technologies, Inc., Reg. No. 37181	DP-306711 CIP1	10/616,490
	Applicant Van Steenkiste et al.	
	Filing Date July 9, 2003	Group 1762

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	3,996,398	12/1976	Manfredi			
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Document Number	Date	Country	Class	Subclass	Translation Yes	No
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McCune, et al; Characterization of Copper And Steel Coatings Made By The Cold Gas-Dynamic Spray Method; National Thermal Spray Conference

Examiner | Date Considered

***Examiner: Initial if reference considered whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.**

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Reg. No. 37181		

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	42 36 911	12-23-1993	Germany				No
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